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Rev. 8 — 19 December 2014

Product data sheet

General description 1.

The PCF2127 is a CMOS¹ Real Time Clock (RTC) and calendar with an integrated Temperature Compensated Crystal (Xtal) Oscillator (TCXO) and a 32.768 kHz quartz crystal optimized for very high accuracy and very low power consumption. The PCF2127 has 512 bytes of general-purpose static RAM, a selectable I²C-bus or SPI-bus, a backup battery switch-over circuit, a programmable watchdog function, a timestamp function, and many other features.

For a selection of NXP Real-Time Clocks, see Table 94 on page 89

Features and benefits 2.

- UL Recognized Component
- Operating temperature range from –40 °C to +85 °C
- Temperature Compensated Crystal Oscillator (TCXO) with integrated capacitors
- Typical accuracy:
 - PCF2127AT: ±3 ppm from –15 °C to +60 °C
 - PCF2127T: ±3 ppm from –30 °C to +80 °C
- Integration of a 32.768 kHz guartz crystal and oscillator in the same package
- Provides year, month, day, weekday, hours, minutes, seconds, and leap year correction
- 512 bytes of general-purpose static RAM
- Timestamp function
 - with interrupt capability
 - detection of two different events on one multilevel input pin (for example, for tamper detection)
- Two line bidirectional 400 kHz Fast-mode I²C-bus interface
- 3 line SPI-bus with separate data input and output (maximum speed 6.5 Mbit/s)
- Battery backup input pin and switch-over circuitry
- Battery backed output voltage
- Battery low detection function
- Extra power fail detection function with input and output pins
- Power-On Reset Override (PORO)
- Oscillator stop detection function
- Interrupt output (open-drain)

The definition of the abbreviations and acronyms used in this data sheet can be found in Section 21. 1.



- Programmable 1 second or 1 minute interrupt
- Programmable watchdog timer with interrupt
- Programmable alarm function with interrupt capability
- Programmable square wave output pin
- Programmable countdown timer with interrupt
- Clock operating voltage: 1.8 V to 4.2 V
- Low supply current: typical 0.70 μA at V_{DD} = 3.3 V

Applications 3.

- Electronic metering for electricity, water, and gas
- Precision timekeeping
- Access to accurate time of the day
- GPS equipment to reduce time to first fix
- Applications that require an accurate process timing
- Products with long automated unattended operation time

Ordering information 4.

Table 1. **Ordering information**

Type number	Package	Package						
	Name	Description	Version					
PCF2127AT	SO20	plastic small outline package; 20 leads; body width 7.5 mm	SOT163-1					
PCF2127T	SO16	plastic small outline package; 16 leads; body width 7.5 mm	SOT162-1					

4.1 Ordering options

Table 2. **Ordering options**

Product type number	Orderable part number	Sales item (12NC)	Delivery form	IC revision
PCF2127AT/2	PCF2127AT/2Y	935299867518	tape and reel, 13 inch, dry pack	2
PCF2127T/2	PCF2127T/2Y	935299866518	tape and reel, 13 inch, dry pack	2

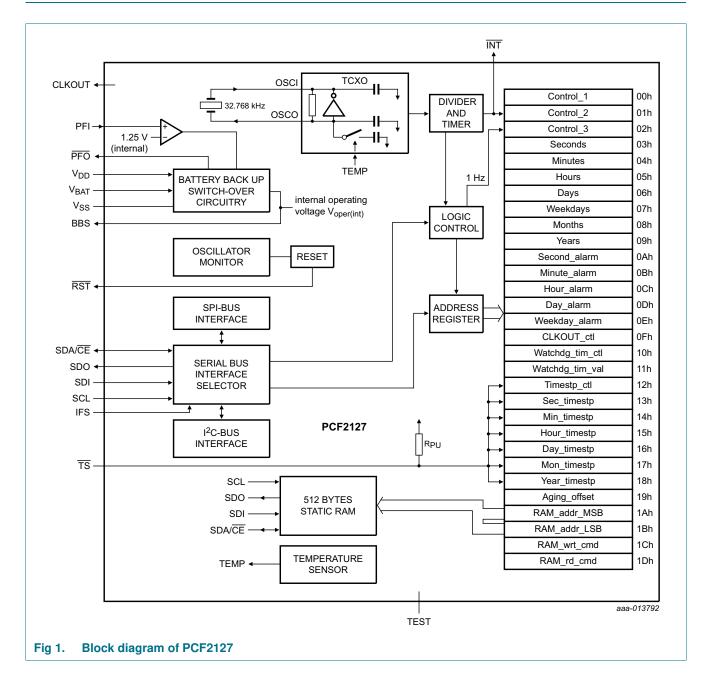
Marking 5.

Table 3. Marking codes

Product type number	Marking code
PCF2127AT/2	PCF2127AT
PCF2127T/2	PCF2127T

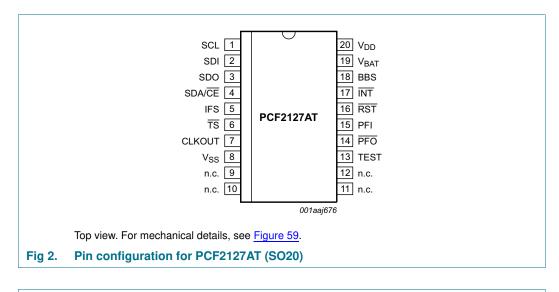
PCF2127 Product data sheet

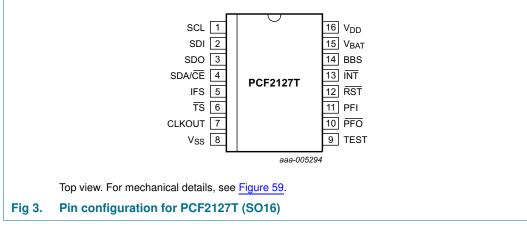
6. Block diagram

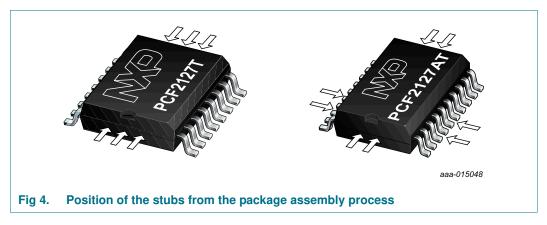


7. Pinning information

7.1 Pinning







After lead forming and cutting, there remain stubs from the package assembly process. These stubs are present at the edge of the package as illustrated in <u>Figure 4</u>. The stubs are at an electrical potential. To avoid malfunction of the PCF2127, it has to be ensured that they are not shorted with another electrical potential (e.g. by condensation).

7.2 Pin description

Table 4. Pin description of PCF2127

Input or input/output pins must always be at a defined level (V_{SS} or V_{DD}) unless otherwise specified.

Symbol	Pin		Description
	PCF2127AT	PCF2127T	
SCL	1	1	combined serial clock input for both I ² C-bus and SPI-bus
SDI	2	2	serial data input for SPI-bus
			connect to pin V _{SS} if I ² C-bus is selected
SDO	3	3	serial data output for SPI-bus, push-pull
SDA/CE	4	4	combined serial data input and output for the I ² C-bus and chip enable input (active LOW) for the SPI-bus
IFS	5	5	interface selector input
			connect to pin V_{SS} to select the SPI-bus
			connect to pin BBS to select the I ² C-bus
TS	6	6	timestamp input (active LOW) with 200 $k\Omega$ internal pull-up resistor ($R_{PU})$
CLKOUT	7	7	clock output (open-drain)
V _{SS}	8	8	ground supply voltage
n.c.	9 to 12	-	not connected; do not connect; do not use as feed through
TEST	13	9	do not connect; do not use as feed through
PFO	14	10	power fail output (open-drain; active LOW)
PFI	15	11	power fail input
RST	16	12	reset output (open-drain; active LOW)
INT	17	13	interrupt output (open-drain; active LOW)
BBS	18	14	output voltage (battery backed)
V _{BAT}	19	15	battery supply voltage (backup)
			connect to $V_{\mbox{\scriptsize SS}}$ if battery switch-over is not used
V _{DD}	20	16	supply voltage

8. Functional description

The PCF2127 is a Real Time Clock (RTC) and calendar with an on-chip Temperature Compensated Crystal (Xtal) Oscillator (TCXO) and a 32.768 kHz quartz crystal integrated into the same package (see <u>Section 8.3.3</u>).

Address and data are transferred by a selectable 400 kHz Fast-mode I²C-bus or a 3 line SPI-bus with separate data input and output (see <u>Section 9</u>). The maximum speed of the SPI-bus is 6.5 Mbit/s.

The PCF2127 has a backup battery input pin and backup battery switch-over circuit which monitors the main power supply. The backup battery switch-over circuit automatically switches to the backup battery when a power failure condition is detected (see <u>Section 8.6.1</u>). Accurate timekeeping is maintained even when the main power supply is interrupted.

A battery low detection circuit monitors the status of the battery (see <u>Section 8.6.2</u>). When the battery voltage drops below a certain threshold value, a flag is set to indicate that the battery must be replaced soon. This ensures the integrity of the data during periods of battery backup.

8.1 Register overview

The PCF2127 contains an auto-incrementing address register: the built-in address register will increment automatically after each read or write of a data byte up to the register 1Bh. After register 1Bh, the auto-incrementing will wrap around to address 00h (see Figure 5).

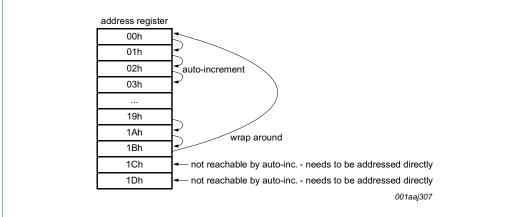


Fig 5. Handling address registers

- The first three registers (memory address 00h, 01h, and 02h) are used as control registers (see <u>Section 8.2</u>).
- The memory addresses 03h through to 09h are used as counters for the clock function (seconds up to years). The date is automatically adjusted for months with fewer than 31 days, including corrections for leap years. The clock can operate in 12-hour mode with an AM/PM indication or in 24-hour mode (see Section 8.9).
- The registers at addresses 0Ah through 0Eh define the alarm function. It can be selected that an interrupt is generated when an alarm event occurs (see <u>Section 8.10</u>).

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- The register at address 0Fh defines the temperature measurement period and the clock out mode. The temperature measurement can be selected from every 4 minutes (default) down to every 30 seconds (see <u>Table 14</u>). CLKOUT frequencies of 32.768 kHz (default) down to 1 Hz for use as system clock, microcontroller clock, and so on, can be chosen (see <u>Table 15</u>).
- The registers at addresses 10h and 11h are used for the watchdog and countdown timer functions. The watchdog timer has four selectable source clocks allowing for timer periods from less than 1 ms to greater than 4 hours (see <u>Table 58</u>). Either the watchdog timer **or** the countdown timer can be enabled (see <u>Section 8.11</u>). For the watchdog timer, it is possible to select whether an interrupt or a pulse on the reset pin is generated when the watchdog times out. For the countdown timer, it is only possible that an interrupt is generated at the end of the countdown.
- The registers at addresses 12h to 18h are used for the timestamp function. When the trigger event happens, the actual time is saved in the timestamp registers (see <u>Section 8.12</u>).
- The register at address 19h is used for the correction of the crystal aging effect (see <u>Section 8.4.1</u>).
- The registers at addresses 1Ah and 1Bh define the RAM address. The register at address 1Ch (RAM_wrt_cmd) is the RAM write command; register 1Dh (RAM_rd_cmd) is the RAM read command. Data is transferred to or from the RAM by the serial interface (see <u>Section 8.5</u>).
- The registers Seconds, Minutes, Hours, Days, Months, and Years are all coded in Binary Coded Decimal (BCD) format to simplify application use. Other registers are either bit-wise or standard binary.

When one of the RTC registers is written or read, the content of all counters is temporarily frozen. This prevents a faulty writing or reading of the clock and calendar during a carry condition (see <u>Section 8.9.8</u>).

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 Table 5.
 Register overview

 Bit positions labeled as - are not implemented and return 0 when read. Bits labeled as T must always be written with logic 0. Bits labeled as X are undefined at
 power-on and unchanged by subsequent resets.

Address	Register name	Bit								Reset value	Reference
		7	6	5	4	3	2	1	0		
Control re	gisters									-	
00h	Control_1	EXT_ TEST	Т	STOP	TSF1	POR_ OVRD	12_24	MI	SI	0000 1000	Table 7 on page 10
01h	Control_2	MSF	WDTF	TSF2	AF	CDTF	TSIE	AIE	CDTIE	0000 0000	Table 9 on page 11
02h	Control_3	P	NRMNG[2:	0]	BTSE	BF	BLF	BIE	BLIE	0000 0000	Table 11 on page 12
Time and	date registers										
03h	Seconds	OSF			SEC	ONDS (0 to	o 59)			1XXX XXXX	Table 28 on page 30
04h 05h 06h 07h 08h 09h Alarm reg 0Ah 0Bh	Minutes	-			MIN	UTES (0 to	59)			- XXX XXXX	Table 31 on page 3
05h	Hours	-	-	AMPM	ŀ	HOURS (1	to 12) in 12	-hour mod	e	XX XXXX	Table 33 on page 33
					HOUF	RS (0 to 23)	in 24-hour	mode		XX XXXX	
06h	Days	-	-			DAYS (1 to 31)			XX XXXX	Table 35 on page 3
07h	Weekdays	-	-	-	-	-	WEE	KDAYS (0	to 6)	XXX	Table 37 on page 33
08h	Months	-	-	-		MO	NTHS (1 to	12)		X XXXX	Table 40 on page 34
09h	Years				YEARS	(0 to 99)				XXXX XXXX	Table 43 on page 3
Alarm reg	isters	1									
0Ah	Second_alarm	AE_S			SECON	D_ALARM	(0 to 59)			1XXX XXXX	Table 45 on page 38
0Bh	Minute_alarm	AE_M			MINUTE	_ALARM ((0 to 59)			1XXX XXXX	Table 47 on page 38
0Ch	Hour_alarm	AE_H	-	AMPM	HOU	JR_ALARM	l (1 to 12) ir	n 12-hour r	node	1 - XX XXXX	Table 49 on page 39
					HOUR_AL	ARM (0 to	23) in 24-h	our mode		1 - XX XXXX	
0Dh	Day_alarm	AE_D	-			DAY_ALAF	RM (1 to 31)			1 - XX XXXX	Table 51 on page 39
0Eh	Weekday_alarm	AE_W	-	-	-	-	WEEKD	AY_ALARN	A (0 to 6)	1 XXX	Table 53 on page 40
CLKOUT of	control register										
0Fh	CLKOUT_ctl	TCR	[1:0]	OTPR	-	-		COF[2:0]		00X 000	Table 13 on page 12
watchdog	registers										
10h	Watchdg_tim_ctl	WD_C	D[1:0]	TI_TP	-	-	-	TF[[1:0]	000 11	Table 55 on page 4
CLKOUT of OFh watchdog 10h 11h Timestam 12h	Watchdg_tim_val			W	ATCHDG_	TIM_VAL[7	:0]			XXXX XXXX	Table 57 on page 42
Timestam	p registers										
12h	Timestp_ctl	TSM	TSOFF	-		1_0_*	6_TIMEST	P[4:0]		00 - X XXXX	Table 68 on page 50

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Accurate RTC with integrated quartz crystal for industrial applications

Table 5. Register overview ...continued

Bit positions labeled as - are not implemented and return 0 when read. Bits labeled as T must always be written with logic 0. Bits labeled as X are undefined at power-on and unchanged by subsequent resets.

Address	Register name	Bit								Reset value	Reference
		7	6	5	4	3	2	1	0	_	
13h	Sec_timestp	-			SECOND_TIMESTP (0 to 59)						Table 70 on page 5
14h	Min_timestp	-			MINUTE		9 (0 to 59)			- XXX XXXX	Table 72 on page 5
15h	Hour_timestp	-	-	AMPM	HOL	JR_TIMEST	P (1 to 12)	in 12-hour	mode	XX XXXX	Table 74 on page 5
					HOUR_TI	MESTP (0 1	to 23) in 24-	hour mode	;	XX XXXX	
16h	Day_timestp	-	-			DAY_TIME	STP (1 to 31	1)		XX XXXX	Table 76 on page 5
17h	Mon_timestp	-	-	-		MONTH	_TIMESTP	(1 to 12)		X XXXX	Table 78 on page 5
18h	Year_timestp			Y	EAR_TIME	ESTP (0 to 9	99)			XXXX XXXX	Table 80 on page 5
Aging offs	set register										1
19h	Aging_offset	-	-	-	-		AO	[3:0]		1000	Table 17 on page 1
RAM regis	sters										
1Ah	RAM_addr_MSB	-	-	-	-	-	-	-	RA8	0	Table 20 on page
1Bh	RAM_addr_LSB			1	RA[7:0]					0000 0000	Table 22 on page
1Ch	RAM_wrt_cmd	Х	Х	Х	Х	Х	Х	Х	Х	XXXX XXXX	Table 23 on page
1Dh	RAM_rd_cmd	Х	Х	Х	Х	Х	Х	Х	Х	XXXX XXXX	Table 24 on page 1

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8.2 Control registers

The first 3 registers of the PCF2127, with the addresses 00h, 01h, and 02h, are used as control registers.

8.2.1 Register Control_1

Table 6. Control_1 - control and status register 1 (address 00h) bit allocation Bits labeled as T must always be written with logic 0.

		,	0					
Bit	7	6	5	4	3	2	1	0
Symbol	EXT_ TEST	Т	STOP	TSF1	POR_ OVRD	12_24	MI	SI
Reset value	0	0	0	0	1	0	0	0

Table 7. Control_1 - control and status register 1 (address 00h) bit description

Bits labeled as T must always be written with logic 0.

Bit	Symbol	Value	Description	Reference		
7	EXT_TEST	0	normal mode	Section 8.14		
		1	external clock test mode	-		
6	Т	0	unused	-		
5	STOP	0	RTC source clock runs	Section 8.15		
		1	RTC clock is stopped;			
			RTC divider chain flip-flops are asynchronously set logic 0;			
			CLKOUT at 32.768 kHz, 16.384 kHz, or 8.192 kHz is still available			
4	TSF1	0	0 no timestamp interrupt generated			
		1	flag set when $\overline{\text{TS}}$ input is driven to an intermediate level between power supply and ground;	-		
			flag must be cleared to clear interrupt			
3	POR_OVRD	0	Power-On Reset Override (PORO) facility disabled;	Section 8.8.2		
			set logic 0 for normal operation			
		1	Power-On Reset Override (PORO) sequence reception enabled			
2	12_24	0	24-hour mode selected	Table 33,		
		1	12-hour mode selected	Table 49, Table 74		
1	MI	0	minute interrupt disabled	Section 8.13.1		
		1	minute interrupt enabled			
0	SI	0	second interrupt disabled			
		1	second interrupt enabled	1		

8.2.2 Register Control_2

Table 8.	Control_2 - control and statu	s register 2 (address 01h) bit allocation
			/ Sit ano oution

Bit	7	6	5	4	3	2	1	0
Symbol	MSF	WDTF	TSF2	AF	CDTF	TSIE	AIE	CDTIE
Reset value	0	0	0	0	0	0	0	0

Table 9. Control_2 - control and status register 2 (address 01h) bit description

Bit	Symbol	Value	Description	Reference	
7	MSF	0	no minute or second interrupt generated	Section 8.13	
		1	flag set when minute or second interrupt generated;	-	
			flag must be cleared to clear interrupt		
6	WDTF	0	no watchdog timer interrupt or reset generated	Section 8.13.4	
		1	flag set when watchdog timer interrupt or reset generated;		
			flag cannot be cleared by command (read-only)		
5	TSF2	0	no timestamp interrupt generated	Section 8.12.1	
		1	1 flag set when TS input is driven to ground;		
			flag must be cleared to clear interrupt		
4	AF	0	no alarm interrupt generated	Section 8.10.6	
		1	flag set when alarm triggered;	-	
			flag must be cleared to clear interrupt		
3	CDTF	0	no countdown timer interrupt generated	Section 8.11.4	
		1	flag set when countdown timer interrupt generated;	-	
			flag must be cleared to clear interrupt		
2	TSIE	0	no interrupt generated from timestamp flag	Section 8.13.6	
		1	interrupt generated when timestamp flag set	-	
1	AIE	0	no interrupt generated from the alarm flag	Section 8.13.5	
		1	interrupt generated when alarm flag set		
0	CDTIE	0	no interrupt generated from countdown timer flag	Section 8.13.2	
		1	interrupt generated when countdown timer flag set	=	

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8.2.3 Register Control_3

Table 10. Control_3 - control and status register 3 (address 02h) bit allocation

Bit	7	6	5	4	3	2	1	0
Symbol	PWRMNG[2:0]			BTSE	BF	BLF	BIE	BLIE
Reset value	0	0	0	0	0	0	0	0

Table 11. Control_3 - control and status register 3 (address 02h) bit description

Bit	Symbol	Value	Description	Reference
7 to 5	PWRMNG[2:0]	see <u>Table 25</u>	control of the battery switch-over, battery low detection, and extra power fail detection functions	Section 8.6
4	BTSE	0	no timestamp when battery switch-over occurs	Section 8.12.4
		1	time-stamped when battery switch-over occurs	
3	BF	0	no battery switch-over interrupt generated	Section 8.6.1
		1	flag set when battery switch-over occurs;	and Section 8.12.4
			flag must be cleared to clear interrupt	<u>Section 6.12.4</u>
2	BLF	0	battery status ok;	Section 8.6.2
			no battery low interrupt generated	
		1	battery status low;	
			flag cannot be cleared by command	
1	BIE	0	no interrupt generated from the battery flag (BF)	Section 8.13.7
		1	interrupt generated when BF is set	
0	BLIE	0	no interrupt generated from battery low flag (BLF)	Section 8.13.8
		1	interrupt generated when BLF is set	

8.3 Register CLKOUT_ctl

Table 12. CLKOUT_ctl - CLKOUT control register (address 0Fh) bit allocation

Bit positions labeled as - are not implemented and return 0 when read. Bits labeled as X are undefined at power-on and unchanged by subsequent resets.

Bit	7	6	5	4	3	2	1	0
Symbol	TCR	[1:0]	OTPR	-	-		COF[2:0]	
Reset value	0	0	Х	-	-	0	0	0

Table 13. CLKOUT ctl - CLKOUT control register (address 0Fh) bit description

Bit positions labeled as - are not implemented and return 0 when read. Bits labeled as X are undefined at power-on and unchanged by subsequent resets.

Bit	Symbol	Value	Description
7 to 6	TCR[1:0]	see Table 14	temperature measurement period
5	OTPR	0	no OTP refresh
		1	OTP refresh performed
4 to 3	-	-	unused
2 to 0	COF[2:0]	see Table 15	CLKOUT frequency selection

8.3.1 Temperature compensated crystal oscillator

The frequency of tuning fork quartz crystal oscillators is temperature-dependent. In the PCF2127, the frequency deviation caused by temperature variation is corrected by adjusting the load capacitance of the crystal oscillator.

The load capacitance is changed by switching between two load capacitance values using a modulation signal with a programmable duty cycle. In order to compensate the spread of the quartz parameters every chip is factory calibrated.

The frequency accuracy can be evaluated by measuring the frequency of the square wave signal available at the output pin CLKOUT. However, the selection of $f_{CLKOUT} = 32.768$ kHz (default value) leads to inaccurate measurements. Accurate frequency measurement occurs when $f_{CLKOUT} = 16.384$ kHz or lower is selected (see Table 15).

8.3.1.1 Temperature measurement

The PCF2127 has a temperature sensor circuit used to perform the temperature compensation of the frequency. The temperature is measured immediately after power-on and then periodically with a period set by the temperature conversion rate TCR[1:0] in the register CLKOUT_ctl.

TCR[1:0]	Temperature measurement period
00 [1]	4 min
01	2 min
10	1 min
11	30 seconds

Table 14. Temperature measurement period

[1] Default value.

8.3.2 OTP refresh

Each IC is calibrated during production and testing of the device. The calibration parameters are stored on EPROM cells called One Time Programmable (OTP) cells. It is recommended to process an OTP refresh once after the power is up and the oscillator is operating stable. The OTP refresh takes less than 100 ms to complete.

To perform an OTP refresh, bit OTPR has to be cleared (set to logic 0) and then set to logic 1 again.

8.3.3 Clock output

A programmable square wave is available at pin CLKOUT. Operation is controlled by the COF[2:0] control bits in register CLKOUT_ctl. Frequencies of 32.768 kHz (default) down to 1 Hz can be generated for use as system clock, microcontroller clock, charge pump input, or for calibrating the oscillator.

CLKOUT is an open-drain output and enabled at power-on. When disabled, the output is high-impedance.

Table 15.	CLKOUT	frequency	selection
-----------	--------	-----------	-----------

COF[2:0]	CLKOUT frequency (Hz)	Typical duty cycle ^[1]
000 [2][3]	32768	60 : 40 to 40 : 60
001	16384	50 : 50
010	8192	50 : 50
011	4096	50 : 50
100	2048	50 : 50
101	1024	50 : 50
110	1	50 : 50
111	CLKOUT = high-Z	-

[1] Duty cycle definition: % HIGH-level time : % LOW-level time.

[2] Default value.

[3] The specified accuracy of the RTC can be only achieved with CLKOUT frequencies not equal to 32.768 kHz or if CLKOUT is disabled.

The duty cycle of the selected clock is not controlled, however, due to the nature of the clock generation all but the 32.768 kHz frequencies are 50 : 50.

8.4 Register Aging_offset

Table 16. Aging_offset - crystal aging offset register (address 19h) bit allocation Bit positions labeled as - are not implemented and return 0 when read.

Bit	7	6	5	4	3	2	1	0
Symbol	-	-	-	-	AO[3:0]			
Reset value	-	-	-	-	1	0	0	0

Table 17. Aging_offset - crystal aging offset register (address 19h) bit description Bit positions labeled as - are not implemented and return 0 when read.

Bit	Symbol	Value	Description
7 to 4	-	-	unused
3 to 0	AO[3:0]	see <u>Table 18</u>	aging offset value

8.4.1 Crystal aging correction

The PCF2127 has an offset register Aging_offset to correct the crystal aging effects².

The accuracy of the frequency of a quartz crystal depends on its aging. The aging offset adds an adjustment, positive or negative, in the temperature compensation circuit which allows correcting the aging effect.

At 25 °C, the aging offset bits allow a frequency correction of typically 1 ppm per AO[3:0] value, from -7 ppm to +8 ppm.

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^{2.} For further information, refer to the application note Ref. 3 "AN11266".

AO[3:0]		ppm	
Decimal	Binary		
0	0000	+8	
1	0001	+7	
2	0010	+6	
3	0011	+5	
4	0100	+4	
5	0101	+3	
6	0110	+2	
7	0111	+1	
8	1000	[1] 0	
9	1001	-1	
10	1010	-2	
11	1011	-3	
12	1100	-4	
13	1101	-5	
14	1110	-6	
15	1111	-7	

Table 18. Frequency correction at 25 °C, typical

[1] Default value.

8.5 General purpose 512 bytes static RAM

The PCF2127 contains a general purpose 512 bytes static RAM. This integrated SRAM is battery backed and can therefore be used to store data which is essential for the application to survive a power outage.

9 bits, RA[8:0], define the RAM address pointer in registers RAM_addr_MSB and RAM_addr_LSB. The register address pointer increments after each read or write automatically up to 1Bh and then wraps around to address 00h (see Figure 5 on page 6).

Data is transferred to or from the RAM by the interface. To write to the RAM, the register RAM_wrt_cmd, to read from the RAM the register RAM_rd_cmd must be addressed explicitly.

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8.5.1 Register RAM_addr_MSB

Table 19. RAM_addr_MSB - RAM address MSB register (address 1Ah) bit allocation

Bit positions labeled as - are not implemented and return 0 when read.

Bit	7	6	5	4	3	2	1	0
Symbol	-	-	-	-	-	-	-	RA8
Reset value	-	-	-	-	-	-	-	0

Table 20. RAM_addr_MSB - RAM address MSB register (address 1Ah) bit description

Bit positions labeled as - are not implemented and return 0 when read.

Bit	Symbol	Description
7 to 1	-	unused
0	RA8	RAM address, MSB (9 th bit)

8.5.2 Register RAM_addr_LSB

Table 21. RAM_addr_LSB - RAM address LSB register (address 1Bh) bit allocation

Bit	7	6	5	4	3	2	1	0	
Symbol	RA[7:0]								
Reset value	0	0	0	0	0	0	0	0	

Table 22. RAM_addr_LSB - RAM address LSB register (address 1Bh) bit description Bit Symbol

Bit	Symbol	Description
7 to 0	RA[7:0]	RAM address, LSB (1 st to 8 th bit)

8.5.3 Register RAM_wrt_cmd

Table 23. RAM_wrt_cmd - RAM write command register (address 1Ch) bit description

Bit	Symbol	Description
7 to 0	-	data to be written into RAM

8.5.4 Register RAM_rd_cmd

Table 24. RAM_rd_cmd - RAM read command register (address 1Dh) bit description

Bit	Symbol	Description
7 to 0	-	data to be read from RAM

8.5.5 Operation examples

8.5.5.1 Writing to the RAM

- 1. Set RAM address:
 - Select register RAM_addr_MSB (send address 1Ah).
 - Set value for bit RA8 (data byte of register 1Ah).
 Note: register address will be incremented automatically to 1Bh.
 - Set value for array RA[7:0] (data byte of register 1Bh).
- 2. Send RAM write command:
 - Select register RAM_wrt_cmd (send address 1Ch).
- 3. Write data into the RAM:
 - Write n data byte into RAM.

For details, see Figure 46 on page 69.

8.5.5.2 Reading from the RAM

- 1. Set RAM address:
 - Select register RAM_addr_MSB (send address 1Ah).
 - Set value for bit RA8 (data byte of register 1Ah).
 Note: register address will be incremented automatically to 1Bh.
 - Set value for array RA[7:0] (data byte of register 1Bh).
- 2. Send RAM read command:
 - Select register RAM_rd_cmd (send address 1Dh).
- 3. Read from the RAM:
 - Read n data byte from the RAM.

For details, see Figure 47 on page 70.

8.6 Power management functions

The PCF2127 has two power supplies:

V_{DD} — the main power supply

 V_{BAT} — the battery backup supply

Internally, the PCF2127 is operating with the internal operating voltage $V_{oper(int)}$ which is also available as V_{BBS} on the battery backed output voltage pin, BBS. Depending on the condition of the main power supply and the selected power management function, $V_{oper(int)}$ is either on the potential of V_{DD} or V_{BAT} (see Section 8.6.4).

Three power management functions are implemented:

Battery switch-over function. monitoring the main power supply V_{DD} and switching to V_{BAT} in case a power fail condition is detected (see <u>Section 8.6.1</u>).

Battery low detection function. monitoring the status of the battery, V_{BAT} (see Section 8.6.2).

Extra power fail detection function. monitoring the voltage at the power fail input pin, PFI (see <u>Section 8.6.3</u>).

The power management functions are controlled by the control bits PWRMNG[2:0] (see <u>Table 25</u>) in register Control_3 (see <u>Table 11</u>):

PWRMNG[2:0]		Function
000	[1]	battery switch-over function is enabled in standard mode;
		battery low detection function is enabled;
		extra power fail detection function is enabled
001		battery switch-over function is enabled in standard mode;
		battery low detection function is disabled;
		extra power fail detection function is enabled
010		battery switch-over function is enabled in standard mode;
		battery low detection function is disabled;
		extra power fail detection function is disabled
011		battery switch-over function is enabled in direct switching mode;
		battery low detection function is enabled;
		extra power fail detection function is enabled
100		battery switch-over function is enabled in direct switching mode;
		battery low detection function is disabled;
		extra power fail detection function is enabled
101		battery switch-over function is enabled in direct switching mode;
		battery low detection function is disabled;
		extra power fail detection function is disabled
110	[2]	battery switch-over function is disabled - only one power supply (V_{DD}) ;
		battery low detection function is disabled;
		extra power fail detection function is enabled
111	[2]	battery switch-over function is disabled - only one power supply (V_{DD}) ;
		battery low detection function is disabled;
		extra power fail detection function is disabled

Table 25. Power management control bit description

[1] Default value.

[2] When the battery switch-over function is disabled, the PCF2127 works only with the power supply V_{DD} . V_{BAT} must be put to ground and the battery low detection function is disabled.

8.6.1 Battery switch-over function

The PCF2127 has a backup battery switch-over circuit which monitors the main power supply V_{DD} . When a power failure condition is detected, it automatically switches to the backup battery.

One of two operation modes can be selected:

Standard mode — the power failure condition happens when:

 $V_{DD} < V_{BAT}$ AND $V_{DD} < V_{th(sw)bat}$

 $V_{th(sw)bat}$ is the battery switch threshold voltage. Typical value is 2.5 V. The battery switch-over in standard mode works only for $V_{DD} > 2.5$ V

Direct switching mode — the power failure condition happens when $V_{DD} < V_{BAT}$. Direct switching from V_{DD} to V_{BAT} without requiring V_{DD} to drop below $V_{th(sw)bat}$

When a power failure condition occurs and the power supply switches to the battery, the following sequence occurs:

- 1. The battery switch flag BF (register Control_3) is set logic 1.
- An interrupt is generated if the control bit BIE (register Control_3) is enabled (see <u>Section 8.13.7</u>).
- 3. If the control bit BTSE (register Control_3) is logic 1, the timestamp registers store the time and date when the battery switch occurred (see <u>Section 8.12.4</u>).
- 4. The battery switch flag BF is cleared by command; it must be cleared to clear the interrupt.

The interface is disabled in battery backup operation:

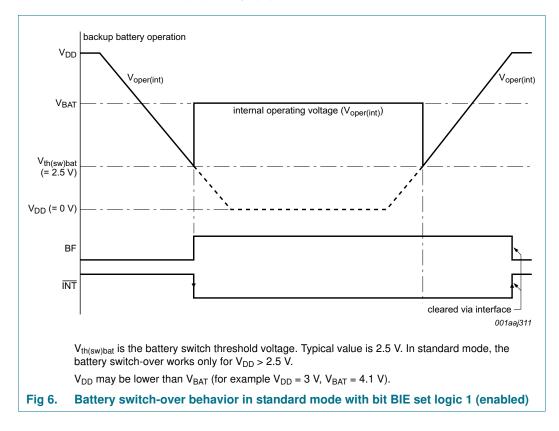
- Interface inputs are not recognized, preventing extraneous data being written to the device
- Interface outputs are high-impedance

For further information about I²C-bus communication and battery backup operation, see <u>Section 9.3 on page 70</u>.

8.6.1.1 Standard mode

If $V_{DD} > V_{BAT}$ OR $V_{DD} > V_{th(sw)bat}$: $V_{oper(int)}$ is at V_{DD} potential.

If V_{DD} < V_{BAT} AND V_{DD} < V_{th(sw)bat}: V_{oper(int)} is at V_{BAT} potential.

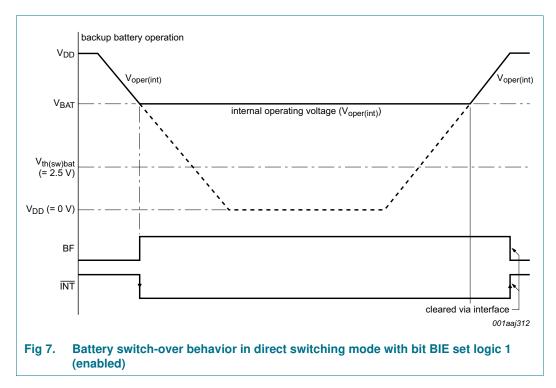


8.6.1.2 Direct switching mode

If $V_{DD} > V_{BAT}$: $V_{oper(int)}$ is at V_{DD} potential.

If $V_{DD} < V_{BAT}$: $V_{oper(int)}$ is at V_{BAT} potential.

The direct switching mode is useful in systems where V_{DD} is always higher than V_{BAT} . This mode is not recommended if the V_{DD} and V_{BAT} values are similar (for example, V_{DD} = 3.3 V, $V_{BAT} \ge 3.0$ V). In direct switching mode, the power consumption is reduced compared to the standard mode because the monitoring of V_{DD} and $V_{th(sw)bat}$ is not performed.



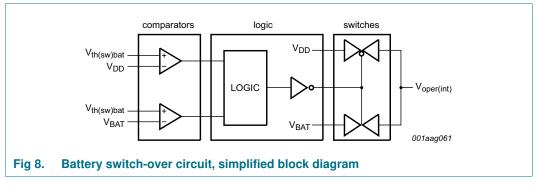
8.6.1.3 Battery switch-over disabled: only one power supply (V_{DD})

When the battery switch-over function is disabled:

- The power supply is applied on the V_{DD} pin
- The V_{BAT} pin must be connected to ground
- V_{oper(int)} is at V_{DD} potential
- The battery flag (BF) is always logic 0

8.6.1.4 Battery switch-over architecture

The architecture of the battery switch-over circuit is shown in Figure 8.



V_{oper(int)} is at V_{DD} or V_{BAT} potential.

Remark: It has to be assured that there are decoupling capacitors on the pins $V_{\text{DD}}, V_{\text{BAT}},$ and BBS.

8.6.2 Battery low detection function

The PCF2127 has a battery low detection circuit which monitors the status of the battery $V_{\text{BAT}}.$

When V_{BAT} drops below the threshold value V_{th(bat)low} (typically 2.5 V), the BLF flag (register Control_3) is set to indicate that the battery is low and that it must be replaced. Monitoring of the battery voltage also occurs during battery operation.

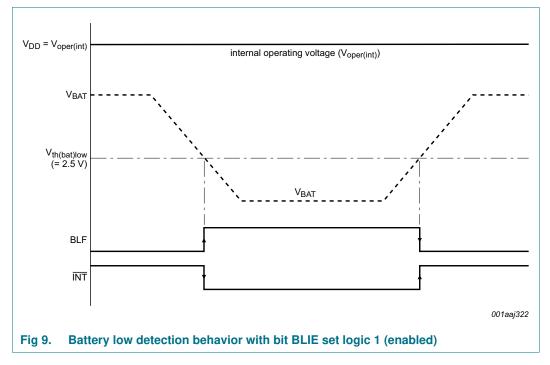
An unreliable battery cannot prevent that the supply voltage drops below V_{low} (typical 1.2 V) and with that the data integrity gets lost. (For further information about V_{low} see <u>Section 8.7</u>.)

When V_{BAT} drops below the threshold value $V_{th(bat)low}$, the following sequence occurs (see Figure 9):

- 1. The battery low flag BLF is set logic 1.
- An interrupt is generated if the control bit BLIE (register Control_3) is enabled (see <u>Section 8.13.8</u>).
- 3. The flag BLF remains logic 1 until the battery is replaced. BLF cannot be cleared by command. It is automatically cleared by the battery low detection circuit when the battery is replaced or when the voltage rises again above the threshold value. This could happen if a super capacitor is used as a backup source and the main power is applied again.

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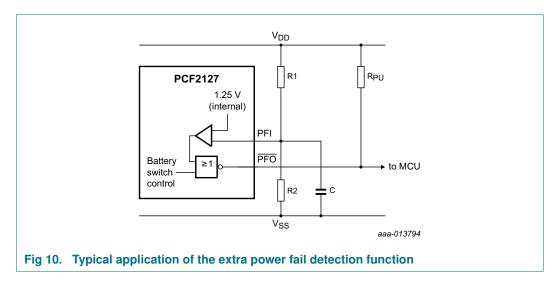


8.6.3 Extra power fail detection function

The PCF2127 has an extra power fail detection circuit which compares the voltage at the power fail input pin PFI to an internal reference voltage equal to 1.25 V.

If $V_{PFI} < 1.25$ V, the power fail output \overline{PFO} is driven LOW. \overline{PFO} is an open-drain, active LOW output which requires an external pull-up resistor in any application.

The extra power fail detection function is typically used as a low voltage detection for the main power supply V_{DD} (see Figure 10).



Usually R1 and R2 should be chosen such that the voltage at pin PFI

- is higher than 1.25 V at start-up
- falls below 1.25 V when V_{DD} falls below a desired threshold voltage, V_{th(uvp)}, defined by <u>Equation 1</u>:

$$V_{th(uvp)} = \left(\frac{R_1}{R_2} + I\right) \times I.25V \tag{1}$$

 $V_{th(uvp)}$ value is usually set to a value that there are several milliseconds before V_{DD} falls below the minimum operating voltage of the system, in order to allow the microcontroller to perform early backup operations, like terminating the communication with the PCF2127.

The value of C is determined from Equation 2:

$$C = \frac{0.02}{(R_1/R_2)} \left[\frac{As}{V}\right]$$
(2)

If the extra power fail detection function is not used, pin PFI must be connected to V_{SS} and pin PFO must be left open circuit.

8.6.3.1 Extra power fail detection when the battery switch-over function is enabled

- When the power switches to the backup battery supply V_{BAT}, the power fail comparator is switched off and the power fail output at pin PFO goes (or remains) LOW
- When the power switches back to the main V_{DD} , the pin \overline{PFO} is not driven LOW anymore. It is pulled HIGH through the external pull-up resistance for a certain time (t_{rec} = 15.63 ms to 31.25 ms). Then the power fail comparator is enabled again

For illustration, see Figure 11 and Figure 12.

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